

N- AND P-Channel Enhancement Mode MOSFET

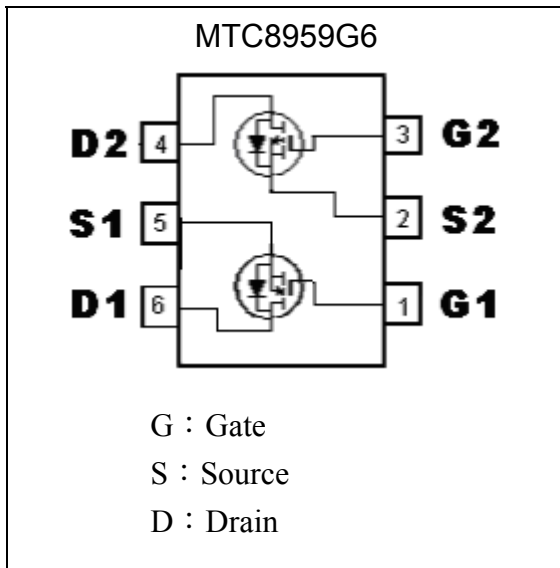
MTC8959G6

	N-CH	P-CH
BV_{DSS}	100V	-100V
I_D	1.4A($V_{GS}=10V$)	-1.1A($V_{GS}=-10V$)
$R_{DSON(TYP.)}$	280m Ω ($V_{GS}=10V$)	450m Ω ($V_{GS}=-10V$)
	295m Ω ($V_{GS}=4.5V$)	500m Ω ($V_{GS}=-4.5V$)

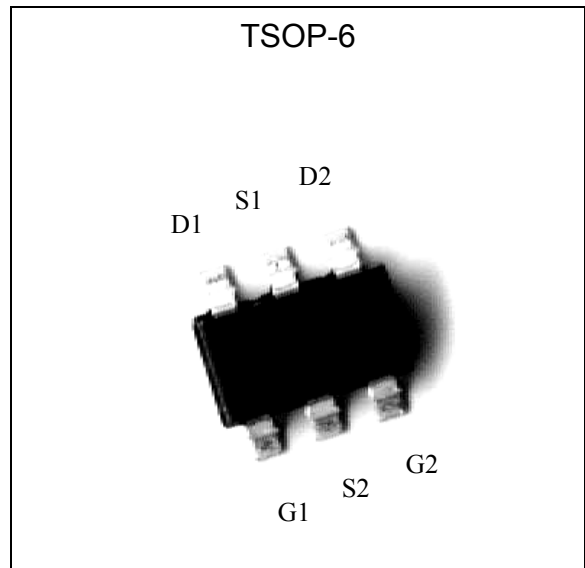
Features

- Simple drive requirement
- Low gate charge
- Low on-resistance
- Fast switching speed
- Pb-free package

Equivalent Circuit

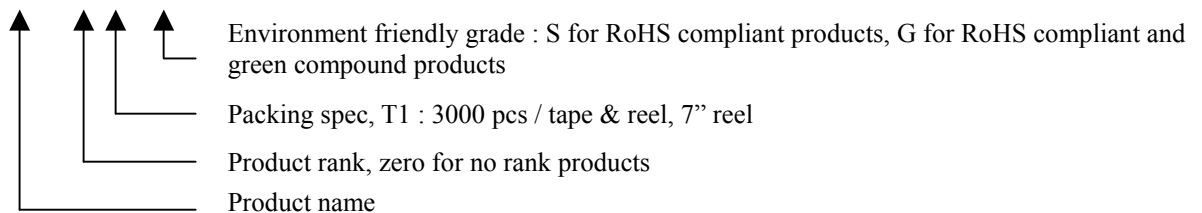


Outline



Ordering Information

Device	Package	Shipping
MTC8959G6-0-T1-G	TSOP-6 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel





Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Limits		Unit	
		N-channel	P-channel		
Drain-Source Breakdown Voltage	BV _{DSS}	100	-100	V	
Gate-Source Voltage	V _{GS}	±20	±20	V	
Continuous Drain Current (Note 1)	T _A =25°C, V _{GS} =10V(N-CH), V _{GS} =-10V(P-CH)	I _D	1.4	-1.1	A
	T _A =70°C, V _{GS} =10V(N-CH), V _{GS} =-10V(P-CH)	I _D	1.1	-0.88	A
Pulsed Drain Current (Note 2)	I _{DM}	5.6	-4.4	A	
Total Power Dissipation (Note 1) Linear Derating Factor	P _d	1.25		W	
		0.01		W / °C	
Operating Junction and Storage Temperature	T _j , T _{stg}	-55~+150		°C	
Thermal Resistance, Junction-to-Ambient (Note 1)	R _{th,ja}	100		°C/W	

Note : 1.Surface mounted on 1 in² copper pad of FR-4 board, t≤5 sec; 180°C/W when mounted on minimum copper pad
 2.Pulse width limited by maximum junction temperature

N-Channel Electrical Characteristics (Tj=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	100	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1	1.9	2.5	V	V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =80V, V _{GS} =0V
I _{DSS}	-	-	10	μA	V _{DS} =80V, V _{GS} =0V, T _j =70°C
*R _{Ds(ON)}	-	280	420	mΩ	V _{GS} =10V, I _D =1.4A
	-	295	450		V _{GS} =4.5V, I _D =1A
*G _{FS}	-	2.5	-	S	V _{DS} =10V, I _D =1.4A
Dynamic					
C _{iss}	-	545	-	pF	V _{DS} =30V, V _{GS} =0V, f=1MHz
C _{oss}	-	14	-		
C _{rss}	-	11	-		
*t _{d(ON)}	-	9	-	ns	V _{DS} =50V, I _D =1A, V _{GS} =10V, R _G =10Ω
*t _r	-	26	-		
*t _{d(OFF)}	-	39	-		
*t _f	-	9	-		
*Q _g	-	6.8	-	nC	V _{DS} =50V, I _D =1.4A, V _{GS} =10V
*Q _{gs}	-	1.4	-		
*Q _{gd}	-	2.4	-		
Source-Drain Diode					
*V _{SD}	-	0.77	1.2	V	V _{GS} =0V, I _S =1A
*t _{rr}	-	15	-	ns	I _F =1A, V _{GS} =0V, dI _F /dt=100A/μs
*Q _{rr}	-	8	-	nC	

*Pulse Test : Pulse Width ≤300μs, Duty Cycle ≤2%



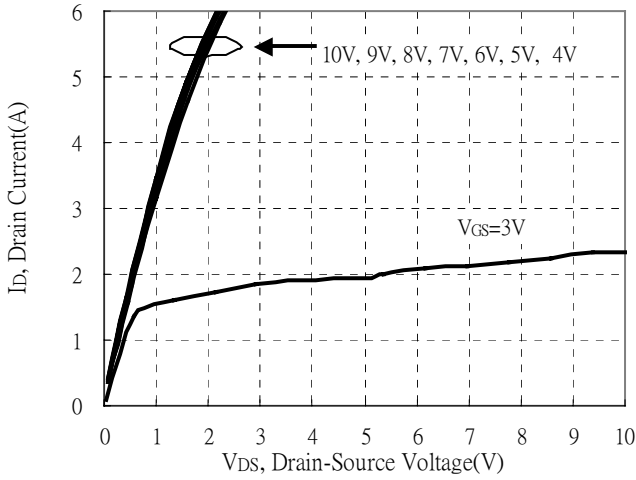
P-Channel Electrical Characteristics (Tj=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	-100	-	-	V	V _{GS} =0V, I _D =-250μA
V _{GS(th)}	-1.0	-1.9	-2.5	V	V _{DS} =V _{GS} , I _D =-250μA
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	-1	μA	V _{DS} =-80V, V _{GS} =0V
I _{DSS}	-	-	-10	μA	V _{DS} =-80V, V _{GS} =0V, Tj=70°C
*R _{DS(ON)}	-	450	600	mΩ	V _{GS} =-10V, I _D =-0.6A
	-	500	700		V _{GS} =-4.5V, I _D =-0.4A
*G _{FS}	-	1.8	-	S	V _{DS} =-10V, I _D =-0.6A
Dynamic					
C _{iss}	-	516	-	pF	V _{DS} =-30V, V _{GS} =0V, f=1MHz
C _{oss}	-	16	-		
C _{rss}	-	12	-		
*t _{d(ON)}	-	9	-	ns	V _{DS} =-50V, I _D =-1A, V _{GS} =-10V, R _G =10Ω
*t _r	-	26	-		
*t _{d(OFF)}	-	36	-		
*t _f	-	9	-		
*Q _g	-	6.5	-	nC	V _{DS} =-50V, I _D =-1.1A, V _{GS} =-10V
*Q _{gs}	-	1.2	-		
*Q _{gd}	-	2.4	-		
Source-Drain Diode					
*V _{SD}	-	-0.81	-1.2	V	V _{GS} =0V, I _S =-1A
*t _{rr}	-	14	-	ns	I _F =-1A, V _{GS} =0V, dI _F /dt=100A/μs
*Q _{rr}	-	8	-	nC	

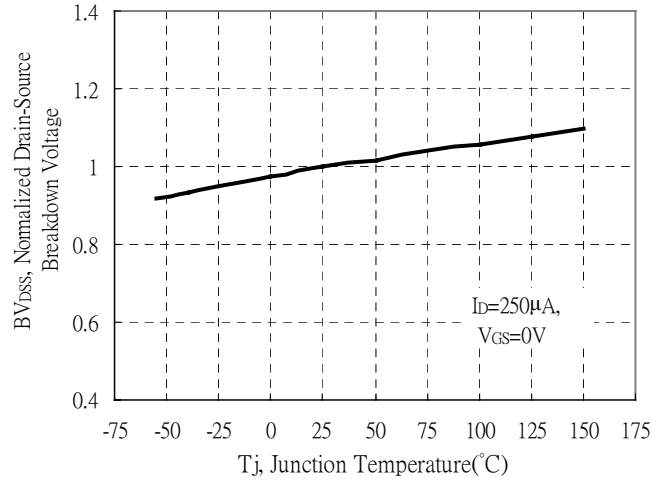
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

N-channel Typical Characteristics

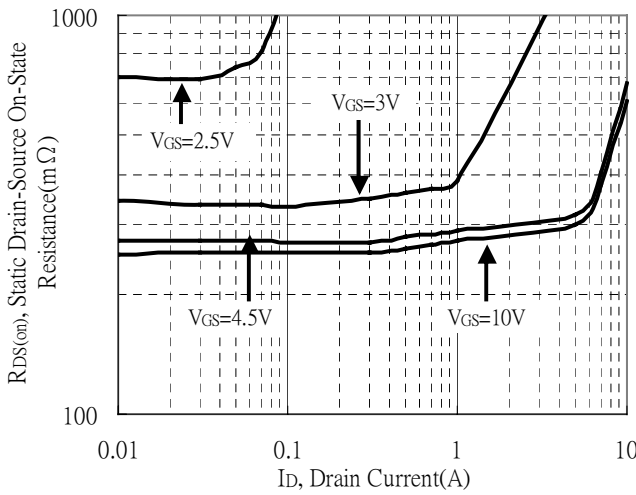
Typical Output Characteristics



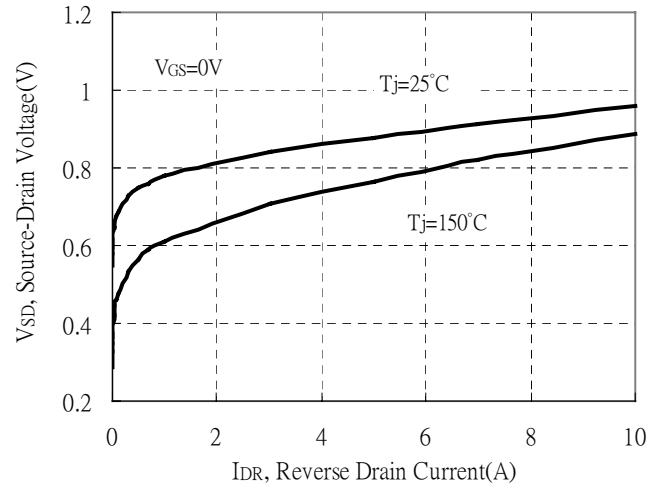
Brekdown Voltage vs Ambient Temperature



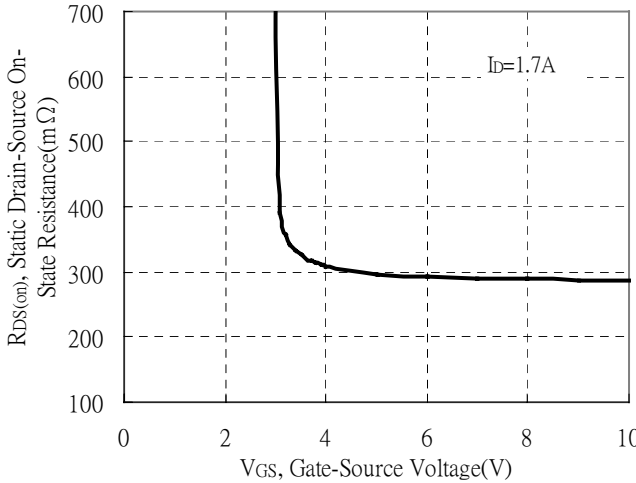
Static Drain-Source On-State resistance vs Drain Current



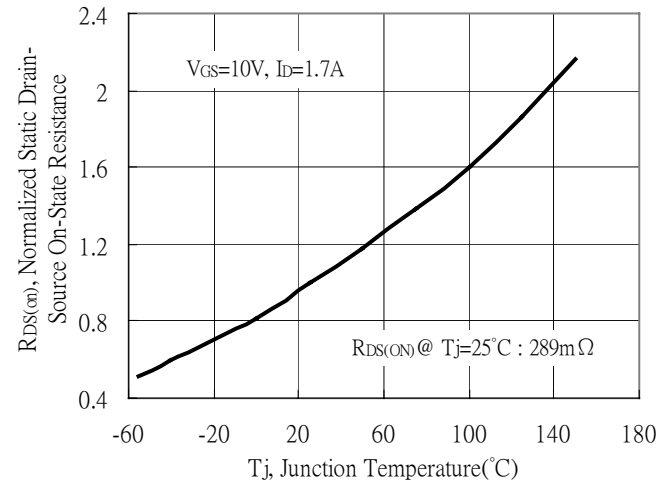
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

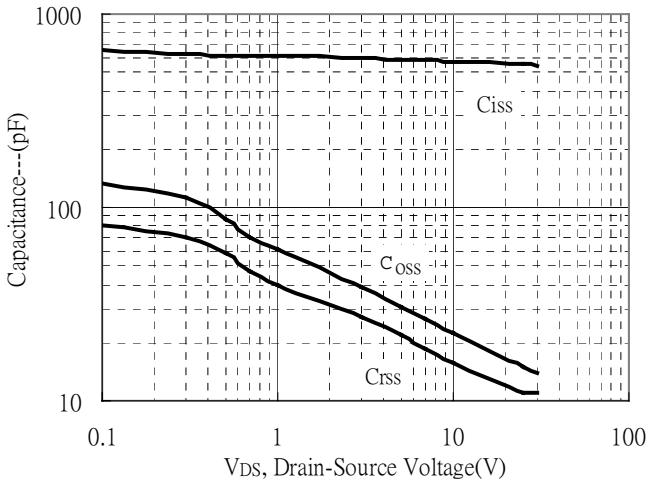


Drain-Source On-State Resistance vs Junction Temperature

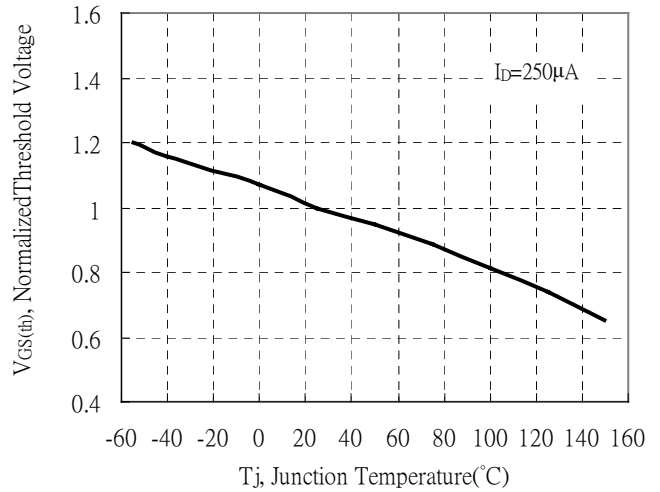


N-channel Typical Characteristics(Cont.)

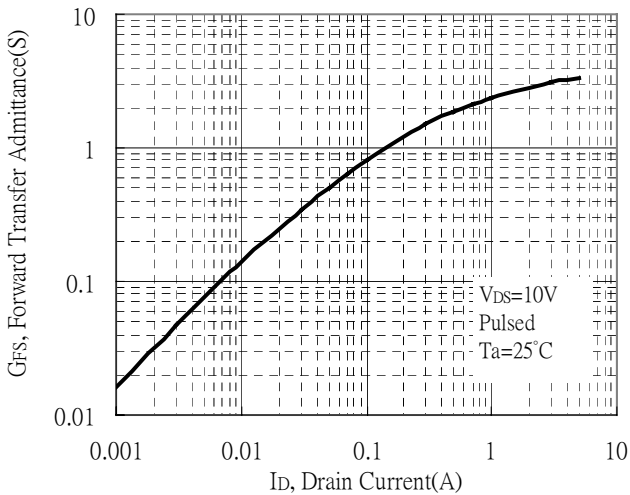
Capacitance vs Drain-to-Source Voltage



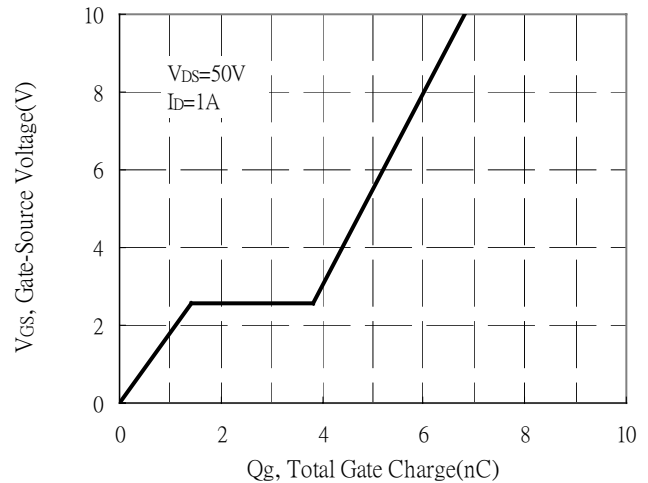
Threshold Voltage vs Junction Temperature



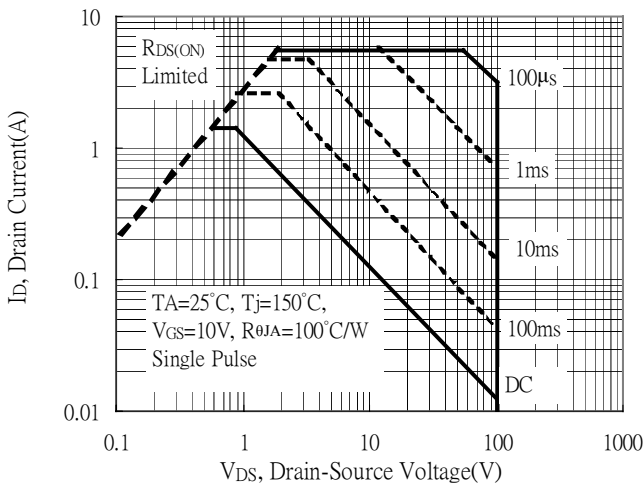
Forward Transfer Admittance vs Drain Current



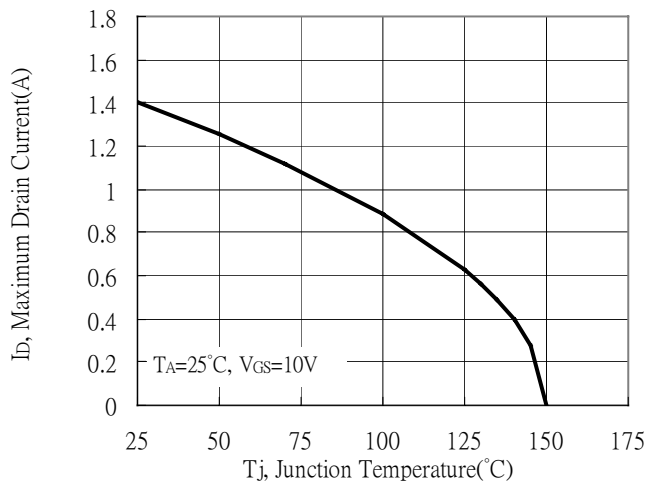
Gate Charge Characteristics



Maximum Safe Operating Area

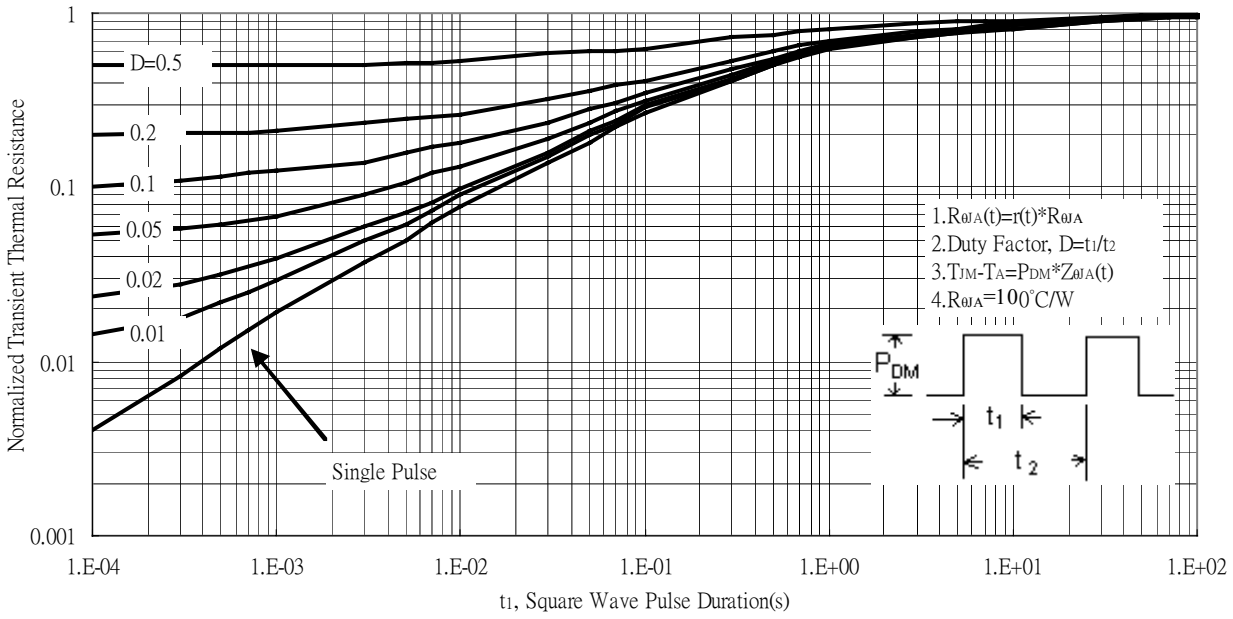


Maximum Drain Current vs Junction Temperature



N-channel Typical Characteristics(Cont.)

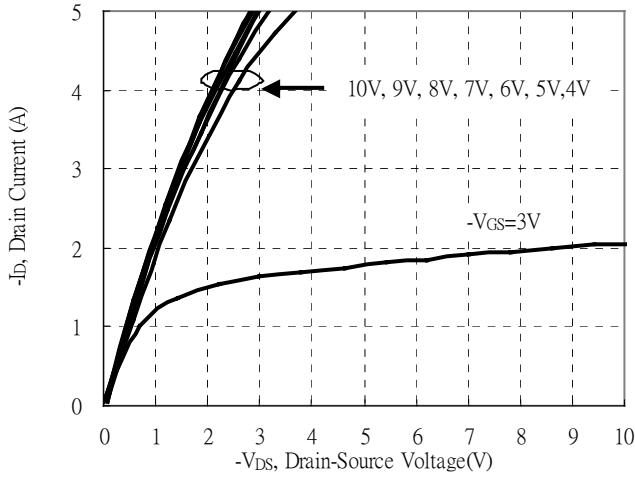
Transient Thermal Response Curves



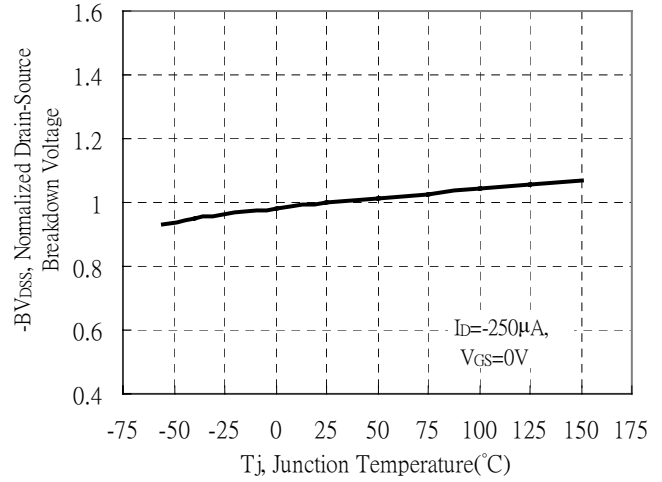


P-channel Typical Characteristics

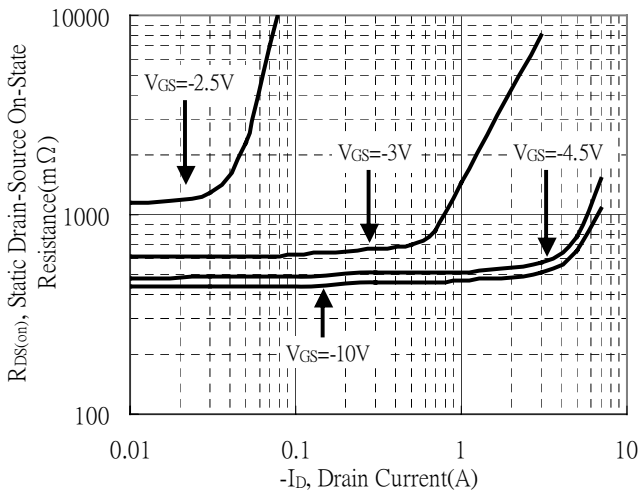
Typical Output Characteristics



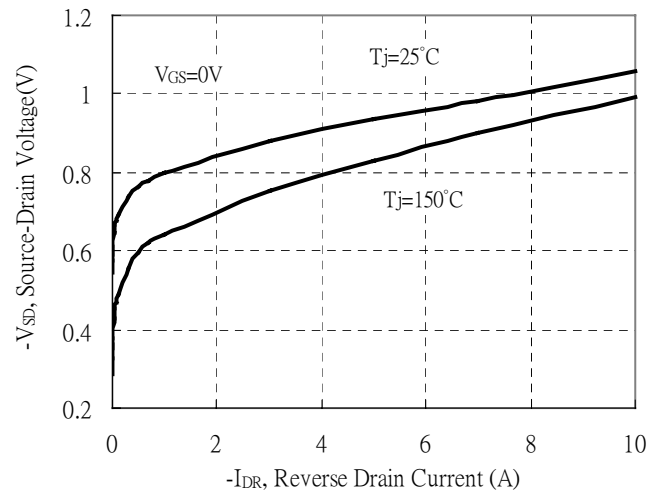
Brekdown Voltage vs Ambient Temperature



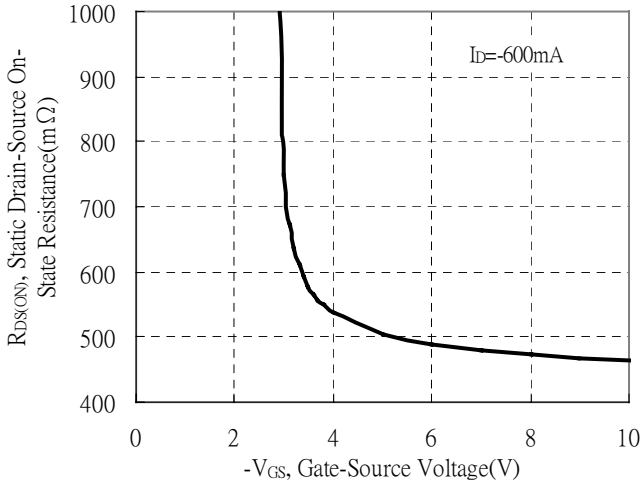
Static Drain-Source On-State resistance vs Drain Current



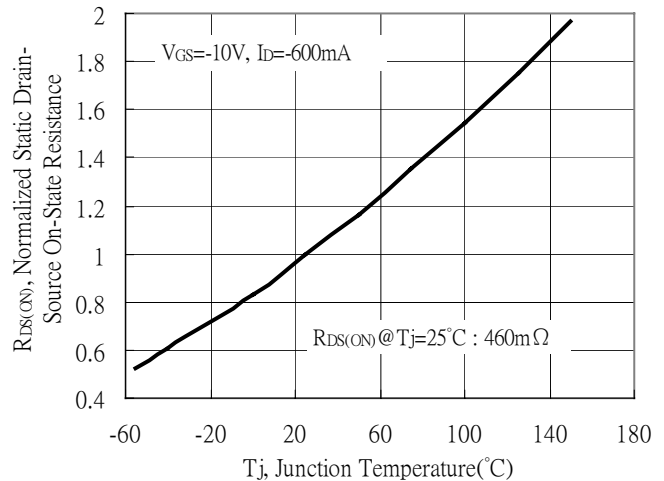
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

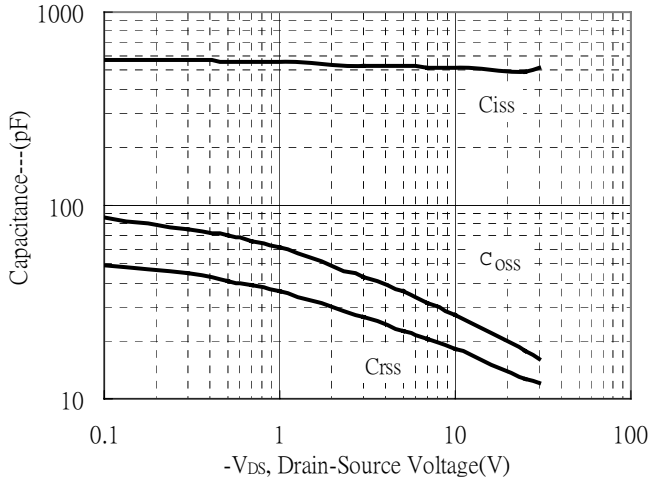


Drain-Source On-State Resistance vs Junction Temperature

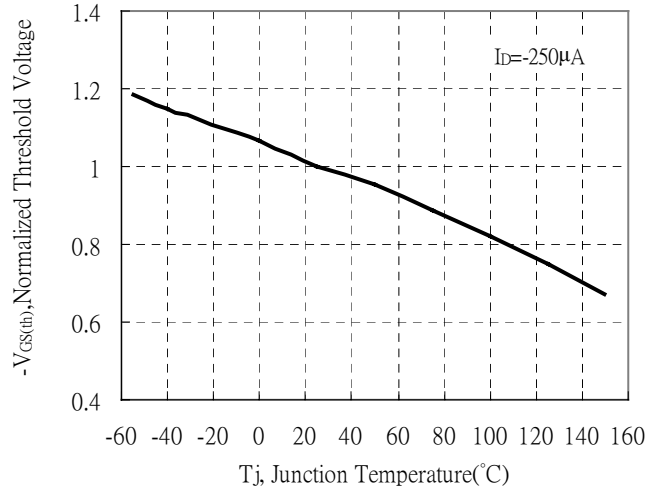


P-channel Typical Characteristics(Cont.)

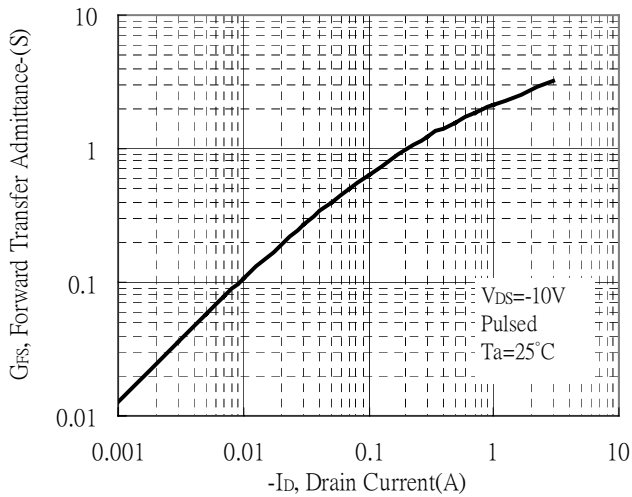
Capacitance vs Drain-to-Source Voltage



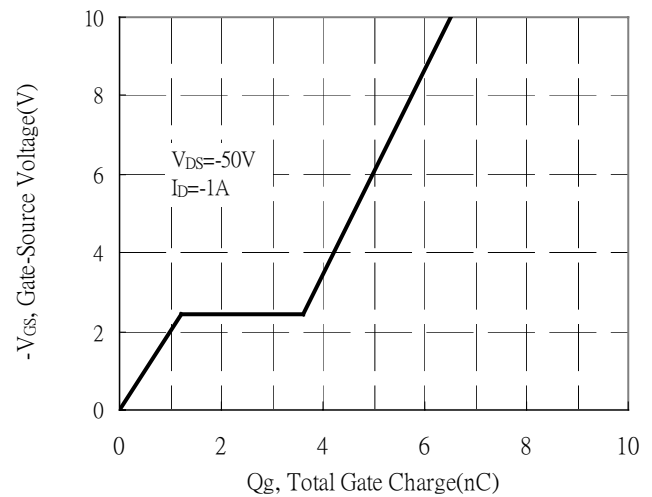
Threshold Voltage vs Junction Temperature



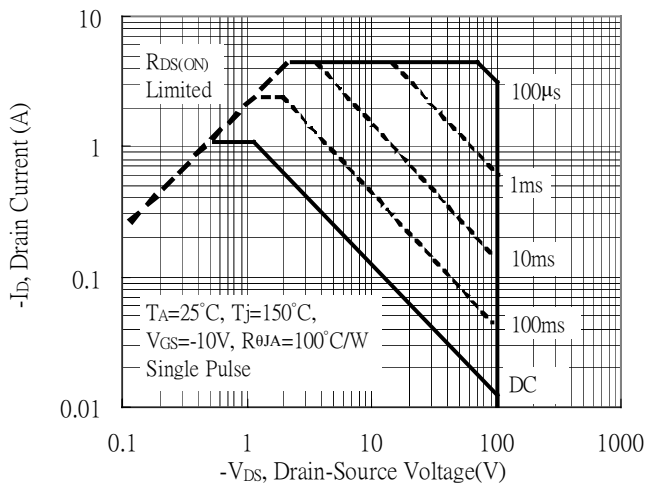
Forward Transfer Admittance vs Drain Current



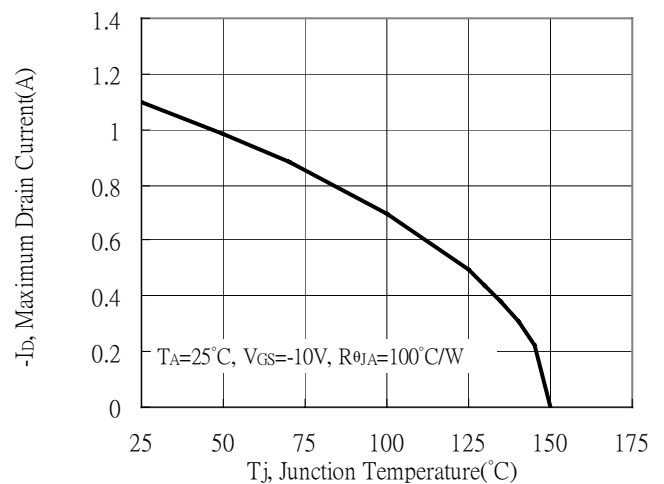
Gate Charge Characteristics



Maximum Safe Operating Area

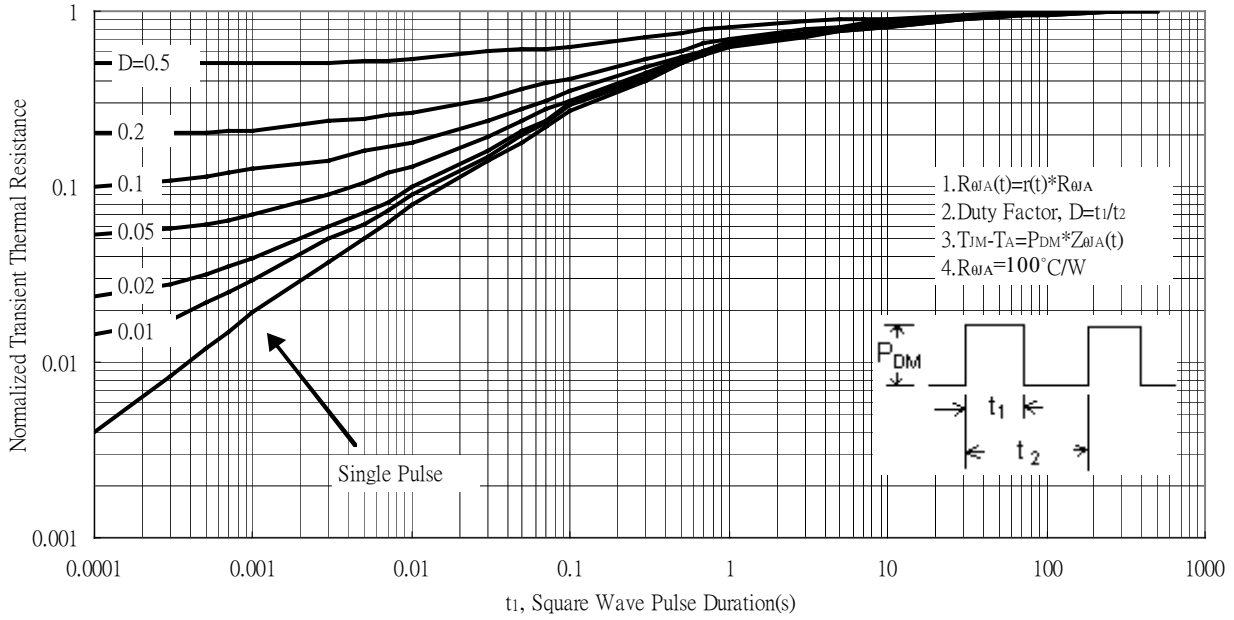


Maximum Drain Current vs Junction Temperature

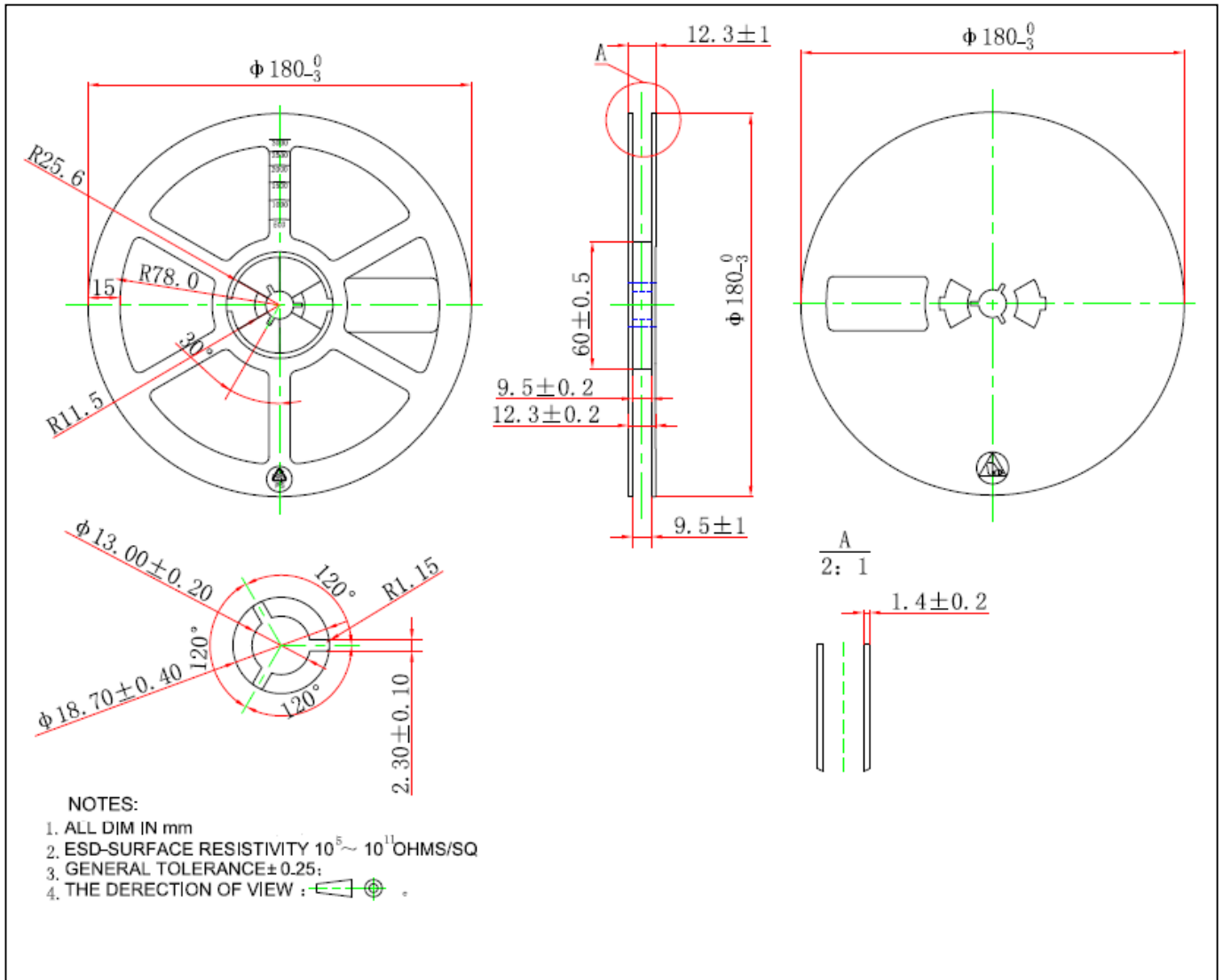


P-channel Typical Characteristics(Cont.)

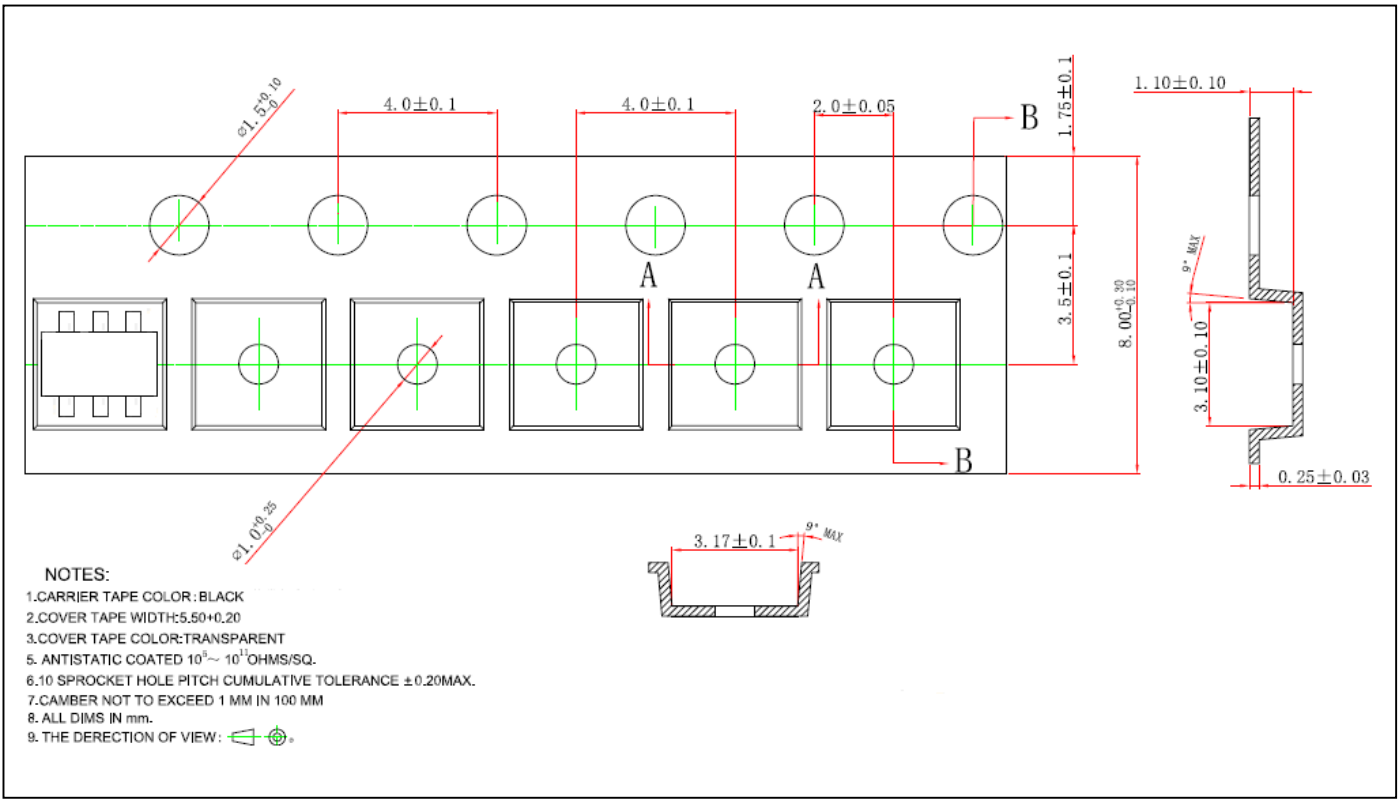
Transient Thermal Response Curves



Reel Dimension



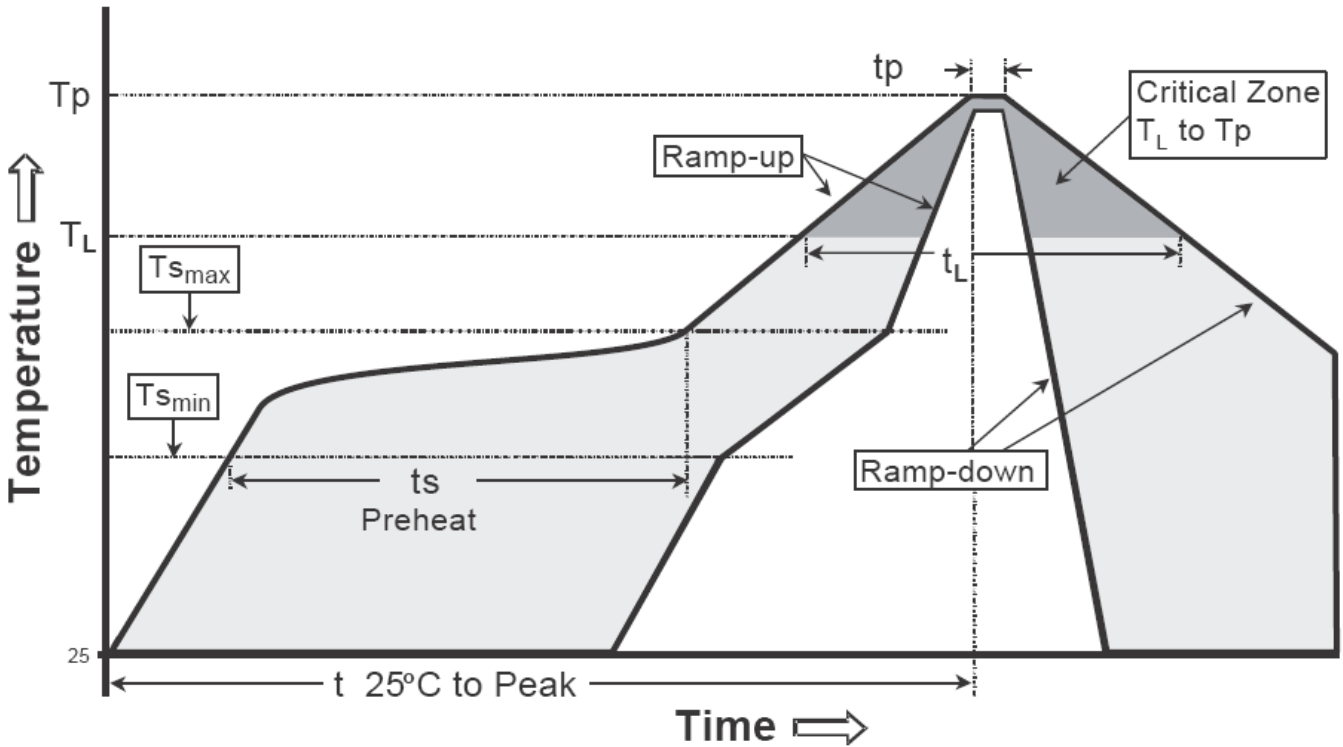
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

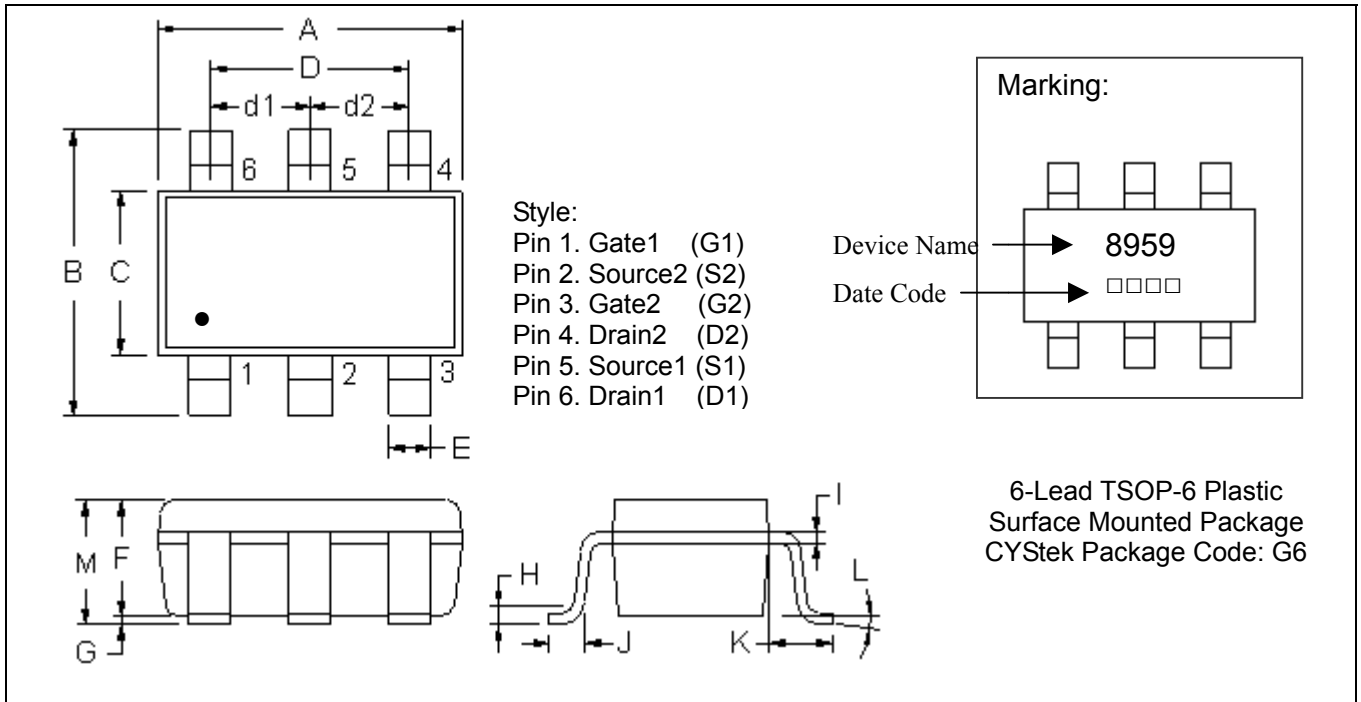
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

TSOP-6 Dimension



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1063	0.1220	2.70	3.10	G	0	0.0039	0	0.10
B	0.1024	0.1181	2.60	3.00	H	-	0.0098	-	0.25
C	0.0551	0.0709	1.40	1.80	I	0.0047 REF		0.12 REF	
D	0.0748 REF		1.90 REF		J	0.0177 REF		0.45 REF	
d1	0.0374 REF		0.95 REF		K	0.0236 REF		0.60 REF	
d2	0.0374 REF		0.95 REF		L	0°	10°	0°	10°
E	0.0118	0.0197	0.30	0.50	M	-	0.0433	-	1.10
F	0.0276	0.0394	0.70	1.00					

Notes : 1.Controlling dimension : millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material :

- Lead :Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

Important Notice:

- All rights are reserved. Reproduction in whole or in part is prohibited without the prior written approval of CYStek.
- CYStek reserves the right to make changes to its products without notice.
- CYStek **semiconductor products are not warranted to be suitable for use in Life-Support Applications, or systems.**
- CYStek assumes no liability for any consequence of customer product design, infringement of patents, or application assistance.